

FORM PTO 1449 (modified) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE				ATTY DOCKET NO. <b>PD-203016</b>		APPLICATION NO. <b>10/613,823</b>	
LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary) Date Submitted to PTO: February 26, 2004				APPLICANT <b>M. EROZ et al.</b>			
				FILING DATE <b>July 3, 2003</b>		GROUP <b>2133</b>	
U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
	6,567,465 ✓	May 20, 2003	Goldstein et al.	375	222		
	US 2003/020372 ✓	October 30, 2003	Berezdivin et al.	455	126		
	US 2003/0187899 ✓	October 2, 2003	Ohta	708	520		
	US 2003/0014718 ✓	January 16, 2003	De Souza et al.	714	804		
FOREIGN PATENT DOCUMENTS							
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/OR ABSTRACT	
	WO 03/088504- A1	October 23, 2003	PCT	H03M	13/23	Abstract in English	
	WO 03/065591- A2	August 7, 2003	PCT	H03M	13/39		
	WO 02/099976- A2	December 12, 2002	PCT	H03M	13/00		
	EP 1 093 231 ✓ A1	April 18, 2001	EPO	H03M	13/00	Abstract in English	
OTHER DOCUMENT(S) (Including Author, Title, Data, Pertinent Pages, etc.)							
	B. Vasic, "Structured Iteratively Decodable Codes Based on Steiner Systems and Their Application in Magnetic Recording", Proceedings, IEEE Global Telecommunications Conference 2001, pp. 2954-2960, November 25-29, 2001						
	B. Vasic, "Combinatorial Constructions of Low-Density Parity Check Codes for Iterative Decoding", Proceedings, IEEE International Symposium on Information Theory 2002, p. 312, June 30-July 5, 2002						
	R. Echard et al., "The Pi-Rotation Low-Density Parity Check Codes", Proceedings, IEEE Global Telecommunications Conference 2001, pp. 980-984, November 25-29, 2001						
	B. Vasic et al, "Kirkman Systems and Their Application in Perpendicular Magnetic Recording", IEEE Transactions on Magnetics, Vol. 38, No. 4, pp. 1705-1710, July 2002						
	L. Ping et al., "Low Density Parity Check Codes with Semi-Random Parity Check Matrix", Electronics Letters, IEE Stevenage, Vol. 35, No. 1, pp. 38-39, January 7, 1999						
	T. Richardson et al., "Efficient Encoding of Low-Density Parity Check Codes", IEEE Transactions on Information Theory, Vol. 47, No. 2, pp. 638-656, February 2001						
	S. Johnson et al., "Construction of Low-Density Parity-Check Codes from Kirkman Triple Systems", Proceedings, IEEE Global Telecommunications Conference 2001, pp. 970-974, November 25-29, 2001						
EXAMINER  DATE CONSIDERED <b>4/16/06</b>							

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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PTO/SB/08A (08-03)

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Substitute for form 1449/PTO  <b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b> (Use as many sheets as necessary)	<b>Complete if Known</b>	
	Application Number	10/613,823
	Filing Date	July 3, 2003
	First Named Inventor	Mustafa Eroz
	Art Unit	2133
	Examiner Name	To be determined
Sheet 1 of 1	Attorney Docket Number	PD-203016

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No.	Document Number Number-Kind Code	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
OK		US 2002/0051501	05-02-2002	Demjanenko, Victor et al.	
		US 2002/0042899	04-11-2002	Tzannes, Marcos C. et al.	

FOREIGN PATENT DOCUMENTS						
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Examiner Signature		Date Considered	4/16/06
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